

Module 5: Understanding of applications of renewal theory, Stationary Process with discrete and continuous parameters

Lecture 21: Theoretical Background for the Simulation Study to study Sequential Sampling Procedures

The Lecture Contains:

- Simulation study using Gamma distribution
- Simulation study using Extreme Value Distribution
- Simulation study using Normal distribution
- Simulation study using Exponential distribution

◀ Previous Next ▶

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Simulation study using Normal distribution: Suppose $X \sim N(\mu, \sigma^2)$, and one is interested to estimate the location parameter, μ . Now in order to compare the efficiencies of the multistage sampling procedures we consider the bounded risk estimation problem of μ , for both (i) SEL and (ii) **linear exponential** (LINEX) loss functions. The estimate of μ is $\hat{\mu} = \bar{X}_n = \frac{1}{n} \sum_{i=1}^n X_i$, and the bounded SEL

and LINEX loss risk problems may be written as $\left\{ R(\bar{X}_n, \mu) = E[(\bar{X}_n - \mu)^2] = \frac{\sigma^2}{n} \leq w \right\}$ and

$\left\{ R(\bar{X}_n, \mu) = E[e^{-a(\bar{X}_n - \mu)} - a(\bar{X}_n - \mu) - 1] = \left(e^{\frac{a^2 \sigma^2}{2n}} - 1 \right) \leq w \right\}$, respectively. The corresponding optimal

sample sizes, with a known value of the scale parameter, σ , are then $D \geq \left(\frac{\sigma^2}{w} \right)$ and

$D \geq \left\{ \frac{a^2 \sigma^2}{2 \log_e(1+w)} \right\}$ respectively. In case σ is unknown, then both the bounded risk problems may be solved using different adaptive sampling procedures.

Simulation study using Exponential distribution: Consider the exponential distribution, $X \sim E(\sigma, \lambda)$, with location parameter, λ and scale parameter as σ . We highlight the advantages of using sequential sampling procedures when one is interested to estimate, λ . If (X_1, X_2, \dots, X_n) is the set of sample observations, then the best estimate of λ is $X_{(1)} = \min\{X_1, X_2, \dots, X_n\}$, for both known and unknown σ values. Now the bounded SEL risk problem may be formulated as

$\left\{ R(X_{(1)}, \lambda) = E[(X_{(1)} - \lambda)^2] = \frac{\sigma^2}{n^2} \leq w \right\}$, while the counterpart for LINEX loss bounded risk is

$\left\{ R(X_{(1)}, \lambda) = E[e^{-a(X_{(1)} - \lambda)} - a(X_{(1)} - \lambda) - 1] = \left[\frac{1}{1 - \left(\frac{a\sigma}{n} \right)} - \left(\frac{a\sigma}{n} \right) - 1 \right] \leq w \right\}$. The corresponding

optimal sample sizes, are $D \geq \left(\sqrt{\frac{\sigma^2}{w}} \right)$ and $D \geq \frac{1}{2} \left\{ a + \left| a \left(1 + \frac{4}{w} \right)^{\frac{1}{2}} \right| \right\} \sigma$ respectively. So with σ being

unknown, one may solve both these bounded risk problems using different multi-stage sampling methodologies.

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Simulation study using Gamma distribution: Next assume $X \sim G(\alpha, \beta, \gamma)$, i.e., the gamma distribution, where α , β and γ as the *shape*, *scale* and *location* parameters respectively. For simplicity assume $\beta = 1$, $\gamma = 0$, then one can easily see that $\alpha = E(X)$, for which the best estimate is

$\hat{\alpha} = \frac{1}{n} \sum_{i=1}^n X_i$. Considering the bounded SEL and LINEX risk problem for the gamma distribution the

corresponding optimal sample sizes, are respectively given by $D \geq \left(\frac{\alpha}{w} \right)$ and $D \geq \left\{ \frac{a^2 \alpha}{2 \log_e(1+w)} \right\}$

(with $-1 < a < n$). Thus with unknown σ one may solve both these bounded risk problems using any one of the sequential analysis methods discussed earlier.

Simulation study using Extreme Value Distribution: Finally consider $X \sim EVD(\mu, \sigma)$ as the Extreme Value Distribution (EVD) with μ as its location parameter and s as the scale parameter.

We know the estimate of σ is $\hat{\sigma} = \sqrt{\frac{6}{\pi^2}} \times \sqrt{\left(\frac{1}{n-1} \right) \times \sum_{i=1}^n (X_i - \bar{X}_n)^2}$, where $\bar{X}_n = \frac{1}{n} \sum_{i=1}^n X_i$, while that of

μ is $\hat{\mu} = \bar{X}_n - \gamma_E \hat{\sigma}$. Hence the SEL bounded risk optimal sample size is $D \geq \left(\frac{\pi^2 \sigma^2}{6w} \right)$. In case one

considers the LINEX loss function, then the optimal sample size for the bounded LINEX loss risk is

$D \geq \left[\frac{-a^2 \sigma^2}{2 \{ \log_e(1+w+a\gamma\sigma) + a\sigma \}} \right]$, when $|a| \leq \frac{n}{\sigma}$ and $a \neq 0$. Hence to find the optimal estimate of μ

, with unknown s , both these bounded risk problems may be solved employing any one of the sequential sampling methods discussed. Furthermore this estimate of μ may be used to calculate $E(X)$.

Hence one first finds the bounded risk estimate of μ and then calculates $E(X)$ using $\hat{E}(X) = \hat{\mu}_N + \gamma_E \sigma$,

where $\hat{\mu}_N$, is the estimate of μ found using any one of the sequential sampling plans.

◀ Previous Next ▶